

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: S. KASUKABE et al
Application No.: 10/562,797
Filed: 12/29/2005
Title: PROBE CARD AND SEMICONDUCTOR TESTING DEVICE
USING PROBE SHEET OR PROBE CARD AND
SEMICONDUCTOR DEVICE PRODUCING METHOD
Art Unit: 2829 Exr.: R. ISLA RODAS **CONF. No.: 8707**

AMENDMENT AFTER FINAL REJECTION UNDER 37 CFR §1.116

MS: AMENDMENT AFTER FINAL
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

April 7, 2008

Sir:

In response to the Final Office Action dated December 7, 2007, the period of response for which extension is requested by the attached Petition for Extension of Time, please amend the above-identified application as listed below and as set forth on the following pages:

Amendments to the Claims;

Remarks are included following the amendments.

OK TO ENTER: /RI/

04/23/2008